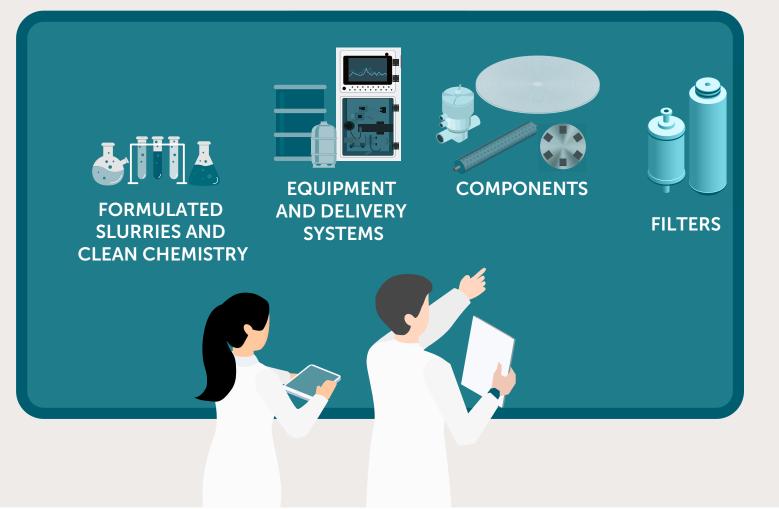
## Finding CMP Synergies to Improve Wafer Performance, Yield, and Variability

Chemical Mechanical Planarization (CMP) is an enabler in device patterning and scaling and a critical determinant of wafer yield. It is more prevalent with newer chip architectures requiring novel materials and multiple CMP passes. The concept is simple: remove excess material and ensure a clean and planar surface for the next process step.

However, reducing defects becomes a growing challenge as the CMP steps evolve. Entegris has a uniquely comprehensive understanding of the CMP process steps and their critical interactions.

## HOLISTIC CMP RESEARCH AND DEVELOPMENT

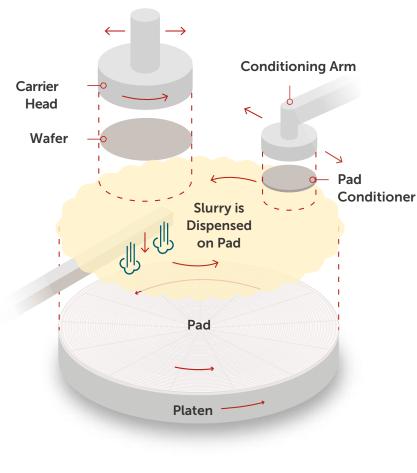
To develop a CMP solution that solves customers' challenges, scientists and process and tool engineers must consider the formulated slurries and clean chemistries, equipment and delivery systems, components, and filters.

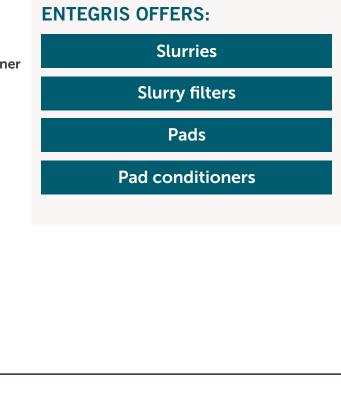


### The CMP process consists of several steps, including multiple sequential polishing steps depending on the type of films. Slurry is the

**SELECTING SLURRY** 

critical material-removing component of the CMP process, and is made up of a combination of DI water, chemicals, and abrasive particles. The choice of slurry must be properly paired with slurry filters to ensure an optimized polishing mechanism. The pad and pad conditioner must be optimized for the CMP process as well.





# **OPTIMIZING PCMP**

**CLEAN TO SLURRY** 

**CMP** 

### the wafer surface must be cleaned with contaminant-free, formulated clean chemistries and mechanical

must be optimized with the slurry. Brush material properties and design must also be considered. pCMP Cleaning Solution

brushes. The selected chemistries

After material removal and polishing,



**PCMP** 

**CLEAN** 



**ENSURING SLURRY** 

Slurry is subject to tight process

control to ensure its integrity while

in use, including particle size, flow

rate, and chemical concentration

**CONSISTENCY** 

monitoring. Particle filtration must also be tightly controlled to prevent both large particles that cause scratching, and small particles that can adhere to the surface and become difficult to remove in PCMP cleaning. **ENTEGRIS OFFERS: Electrochemical analyzer** 

Particle count and size analyzers **Concentration monitors** 

Filters and housings

## blending, storage, filtration, transport, and handling. It is critical that all

**CONTROL** 

materials, components, and equipment that interact in the CMP process are compatible with one another and the chemistry used. **ENTEGRIS OFFERS:** Filters, manifolds, housings

**ENSURING CONTAMINATION** 

Degradation and contamination must

be minimized throughout slurry

### Transport and storage containers Fittings, valves, tubing

**Pressure transducers** 

Integrated flow controllers

**FOUPs** 

# **PUTTING IT ALL TOGETHER**

When the entire system works in sync, contamination decreases and fabs are best able to achieve their CMP yield goals. Sourcing the slurries, components, filters, chemistries, pads, conditioners, brushes, and monitoring tools from Entegris delivers the best on-wafer performance, decreases cost of ownership, and ensures high yield.





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